

Hex-Half-Bridge / Double Six-Driver

TLE 6208-6 G

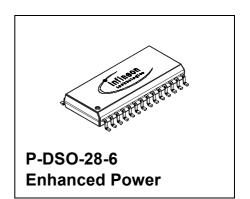
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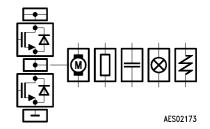
Data Sheet

1 Overview

1.1 Features

- Six High-Side and six Low-Side-Drivers
- Free configurable as switch, halfbridge or H-bridge
- Optimized for DC motor management applications
- 0.6 A continuous (1 A peak) current per switch
- *R*_{DS ON}; typ. 0.8 Ω, @ 25 °C per switch
- Outputs fully short circuit protected with diagnosis
- Overtemperature-Protection with hysteresis and diagnosis
- Temperature prewarning
- Standard SPI-Interface
- Very low current consumption (typ. 10 $\mu A,$ @ 25 $^{\circ}C)$ in stand-by (Inhibit) mode
- Over- and Undervoltage-Lockout
- CMOS/TTL compatible inputs with hysteresis
- Internal clamp diodes
- Enhanced power P-DSO-Package





Туре	Ordering Code	Package
TLE 6208-6 G	Q67007-A9462	P-DSO-28-6

Functional Description

The TLE 6208-6 G is a fully protected **Hex-Half-B**ridge-**D**river designed specifically for automotive and industrial motion control applications. The part is based on Infineons Smart Power Technology SPT[®] which allows bipolar and CMOS control circuitry in accordance with DMOS power devices existing on the same monolithic circuitry. The six low and high side drivers are freely configurable and can be controlled separately. Therefore all kind of loads can be combined. In motion control up to 5 actuators (DC-Motors) can be connected to the 6 halfbridge-outputs (cascade configuration). Operation modes forward (cw), reverse (ccw), brake and high impedance are controlled from a standard SPI-Interface. The possibility to control the outputs via software from a central logic, allows limiting the power dissipation. So the standard P-DSO-28-6-package meets the application requirements and saves PCB-Board-space and cost.

Furthermore the build-in features like Over- and Undervoltage-Lockout, Over-Temperature-Protection and the very low quiescent current in stand-by mode opens a wide range of automotive- and industrial-applications.



1.2 Pin Configuration

(top view)

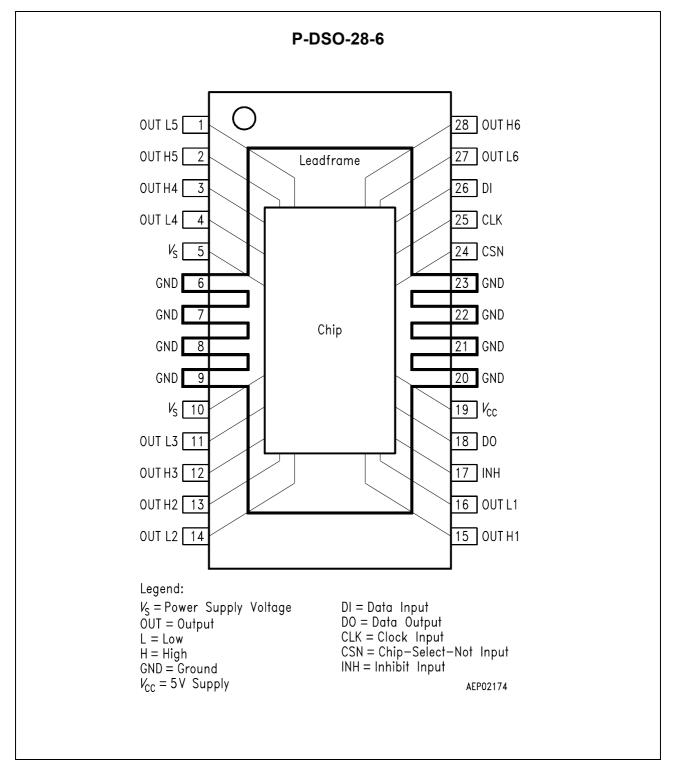


Figure 1



Pin No.	Symbol	Function
1	OUTL5	Low-Side-Output 5; Power-MOS open drain with internal reverse diode; no internal clamp diode or active zenering; short circuit protected and open load controlled.
2	OUTH5	High-Side-Output 5; Power-MOS open source with internal reverse diode; no internal clamp diode or active zenering; short circuit protected and open load controlled.
3	OUTH4	High-Side-Output 4; see pin2.
4	OUTL4	Low-Side-Output 4; see pin1.
5	Vs	Power supply ; external connection to pin 10 necessary; needs a blocking capacitor as close as possible to GND Value: $22 \mu\text{F}$ electrolytic in parallel to 220 nF ceramic.
6, 7, 8, 9	GND	Ground; Reference potential; internal connection to pin 20, 21, 22 and 23; cooling tab; to reduce thermal resistance; place cooling areas on PCB close to this pins.
10	Vs	Power Supply; see pin 5.
11	OUTL3	Low-Side-Output 3; see pin1.
12	OUTH3	High-Side-Output 3; see pin2.
13	OUTH2	High-Side-Output 2; see pin2.
14	OUTL2	Low-Side-Output 2; see pin1.
15	OUTH1	High-Side-Output 1; see pin2.
16	OUTL1	Low-Side-Output 1; see pin1.
17	INH	Inhibit input; has an internal pull down; device is switched in standby condition by pulling the INH terminal low.
18	DO	Serial-Data-Output; this 3-state output transfers diagnosis data to the control device; the output will remain 3-stated unless the device is selected by a low on Chip-Select-Not (CSN); see Table 2 for Diagnosis protocol.
19	V _{cc}	Logic supply voltage; needs a blocking capacitor as close as possible to GND; Value: 10 μ F electrolytic in parallel to 220 nF ceramic.

1.3 Pin Definitions and Functions

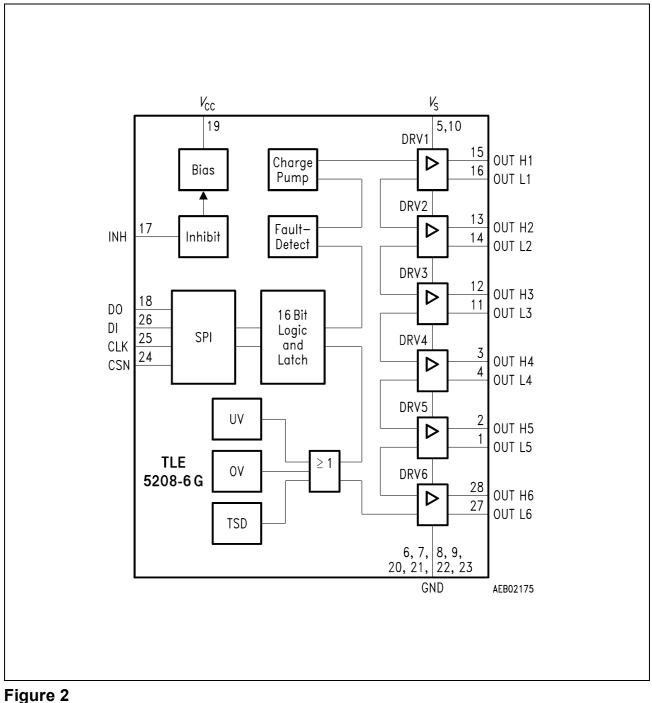


1.3 Pin Definitions and Functions (cont'd)

Pin No.	Symbol	Function
20, 21, 22, 23	GND	Ground
24	CSN	Chip-Select-Not input ; CSN is an active low input; serial communication is enabled by pulling the CSN terminal low; CSN input should only be transitioned when CLK is low; CSN has an internal active pull up and requires CMOS logic level inputs.
25	CLK	Serial clock input ; clocks the shiftregister; CLK has an internal active pull down and requires CMOS logic level inputs.
26	DI	Serial data input; receives serial data from the control device; serial data transmitted to DI is an 16bit control word with the Least Significant Bit (LSB) being transferred first: the input has an active pull down and requires CMOS logic level inputs; DI will accept data on the falling edge of CLK-signal; see Table 1 for input data protocol.
27	OUTL6	Low-Side-Output 6; see pin1.
28	OUTH6	High-Side-Output 6; see pin2.



1.4 Functional Block Diagram



Block Diagram



1.5 Circuit Description

Figure 2 shows a block schematic diagram of the module.

There are 6 halfbridge drivers on the right-hand side. An HS driver and an LS driver are combined to form a halfbridge driver in each case.

The drivers communicate via the internal data bus with the logic and the other control and monitoring functions: undervoltage (UV), overvoltage (OV), overtemperature (TSD), charge pump and fault detect.

Two connection interfaces are provided for supply to the module: All power drivers are connected to the supply voltage V_{s} . These are monitored by overvoltage and undervoltage comparators with hysteresis, so that the correct function can be checked in the application at any time.

The logic is supplied by the $V_{\rm CC}$ voltage, typ. with 5 V. The $V_{\rm CC}$ voltage uses an internally generated Power-On Reset (POR) to initialize the module at power-on. The advantage of this system is that information stored in the logic remains intact in the event of short-term failures in the supply voltage $V_{\rm S}$. The system can therefore continue to operate following $V_{\rm S}$ undervoltage, without having to be reprogrammed. The "undervoltage" information is stored, and can be read out via the interface. The same logically applies for overvoltage. "Interference spikes" on $V_{\rm S}$ are therefore effectively suppressed.

The situation is different in the case of undervoltage on the V_{CC} connection pin. If this occurs, then the internally stored data is deleted, and the output levels are switched to high-impedance status (tristate). The module is initialized by V_{CC} following restart (Power-On Reset = POR).

The 16-bit wide programming word or control word (see **Table 1**) is read in via the DI data input, and this is synchronized with the clock input CLK. The status word appears synchronously at the DO data output (see **Table 2**).

The transmission cycle begins when the chip is selected with the CSN input (H to L). If the CSN input changes from L to H then the word which has been read in becomes the control word. The DO output switches to tristate status at this point, thereby releasing the DO bus circuit for other uses.

The INH inhibit input can be used to cut off the complete module. This reduces the current consumption to just a few μA , and results in the loss of any data stored. The output levels are switched to tristate status. The module is reinitialized with the internally generated POR (Power-On Reset) at restart.

This feature allows the use of this module in battery-operated applications (vehicle body control applications).

Every driver block from DRV 1 to 6 contains a low-side driver and a high-side driver. The output connections have been selected so that each HS driver and LS driver pair can be combined to form a halfbridge by short-circuiting adjacent connections. The full flexibility of the configuration can be achieved by dissecting the halfbridges into "quarter-bridges". **Table 3** shows examples of possible applications.



When commutating inductive loads, the dissipated power peak can be significantly reduced by activating the transistor located parallel to the internal freewheeling diode. A special, integrated "timer" for power ON/OFF times ensures there is no crossover current at the halfbridge.

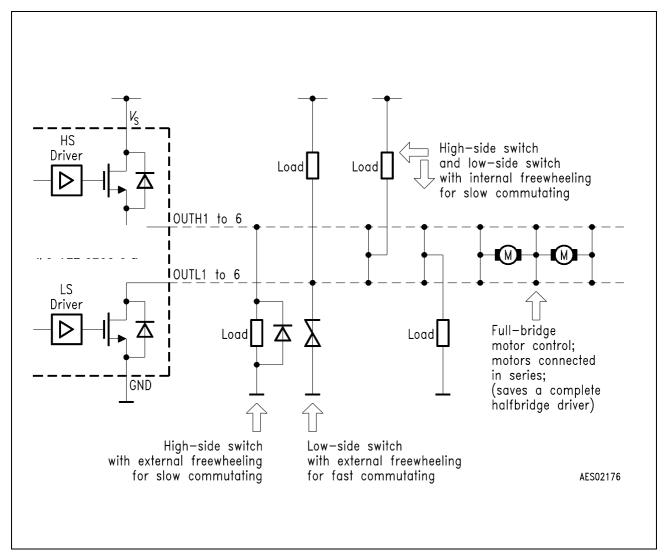


Figure 3 Configuration Examples for "Quarter Bridges" on the TLE 6208-6 G



Table 1 Input Data Protocol

BIT	
15	OVLO on/off
14	Underload SD on/off
13	Overcurrent SD on/off
12	HS-Switch 6
11	LS-Switch 6
10	HS-Switch 5
9	LS-Switch 5
8	HS-Switch 4
7	LS-Switch 4
6	HS-Switch 3
5	LS-Switch 3
4	HS-Switch 2
3	LS-Switch 2
2	HS-Switch 1
1	LS-Switch 1
0	Status Register Reset
H = ON L = OFF	<u>.</u>

Table 2		
Diagnosis	Data	Protocol

BIT	
15	Power supply fail
14	Underload
13	Overload
12	Status HS-Switch 6
11	Status LS-Switch 6
10	Status HS-Switch 5
9	Status LS-Switch 5
8	Status HS-Switch 4
7	Status LS-Switch 4
6	Status HS-Switch 3
5	Status LS-Switch 3
4	Status HS-Switch 2
3	Status LS-Switch 2
2	Status HS-Switch 1
1	Status LS-Switch 1
0	Temp. Prewarning
H = ON	

L = OFF



Table 3 Fault Result Table

Fault	DiagBit	Result			
Overcurrent (load)	13	Only the failed output is switched OFF. Function and protection can be deactivated by bit No. 13.			
Short circuit to GND (high-side-switch)	13	Only the failed output is switched OFF. Function and protection can be deactivated by bit No. 13.			
Short circuit to V_{s} (low-side-switch)	13	Only the failed output is switched OFF. Function and protection can be deactivated by bit No. 13.			
Temperature warning	0	Reaction of control device needed.			
Temperature shut down (SD)	-	All outputs OFF.			
Openload	14	Only the failed output is switched OFF. Function can be deactivated by bit No. 14.			
Underload	14	Only the failed output is switched OFF. Function can be deactivated by bit No. 14.			
Undervoltage lockout (UVLO)	15	All outputs OFF.			
Overvoltage lockout (OVLO)	15	All outputs OFF. Function can be deactivated by bit No. 15.			

H = failure;

L = no failure.



2 Electrical Characteristics

2.1 Absolute Maximum Ratings

Parameter	Symbol	Limit Values		Unit	Remarks
		min.	max.		

Voltages

Supply voltage	Vs	- 0.3	40	V	-
Supply voltage	Vs	– 1	_	V	<i>t</i> < 0.5 s; <i>I</i> _s > – 2 A
Logic supply voltage	V _{CC}	- 0.3	5.5	V	0 V < V _S < 40 V
Logic input voltages (DI, CLK, CSN, INH)	V ₁	- 0.3	5.5	V	$0 V < V_{s} < 40 V$ $0 V < V_{cc} < 5.5 V$
Logic output voltage (DO)	V _{DO}	- 0.3	V _{cc}	V	$0 V < V_{s} < 40 V$ $0 V < V_{cc} < 5.5 V$

Currents

Output current (cont.), if Bit13 (OCSD) is set.	$I_{\rm OUT1-6}$	-	-	A	internal limited
Output current (cont.),	I _{OUT1-6}	- 1.5	1.5	А	V _{DS} = 12 V
if Bit13 (OCSD) is deactivated.		- 0.7	0.7	А	V _{DS} = 20 V
		- 0.25	0.25	А	<i>V</i> _{DS} = 40 V
Output current (peak), if Bit13 (OCSD) is set.	I _{OUT1-6}	-	-	A	internal limited
Output current (peak),	I _{OUT1-6}	- 2	2	А	V _{DS} = 12 V
if Bit13 (OCSD) is deactivated. $t_P < 50$ ms; $t = 1$ s;		- 0.9	0.9	А	V _{DS} = 20 V
$l_{\rm P}$ > 50 ms, $l = 1.8$,		- 0.3	0.3	А	V _{DS} = 40 V

Temperatures

Junction temperature	Tj	- 40	150	°C	-
Storage temperature	$T_{ m stg}$	- 50	150	°C	_

Note: Maximum ratings are absolute ratings; exceeding any one of these values may cause irreversible damage to the integrated circuit.



2.2 Operating Range

Parameter	Symbol	Limit Values		Unit	Remarks
		min.	max.		
Supply voltage	Vs	$V_{\rm UVOFF}$	40	V	After $V_{\rm S}$ rising above $V_{\rm UV ON}$
Supply voltage slew rate	$dV_{\rm S}/dt$	_	10	V/µs	-
Logic supply voltage	V _{cc}	4.75	5.50	V	-
Supply voltage increasing	Vs	- 0.3	$V_{\rm UV ON}$	V	Outputs in tristate
Supply voltage decreasing	Vs	- 0.3	$V_{\rm UVOFF}$	V	Outputs in tristate
Logic input voltage (DI, CLK, CSN, INH)	V ₁	- 0.3	V _{cc}	V	-
SPI clock frequency	$f_{\rm CLK}$	_	2	MHz	-
Junction temperature	Tj	- 40	150	°C	-

Thermal Resistances

Junction pin	$R_{ m thj-pin}$	-	25	K/W	measured to pin 7
Junction ambient	$R_{ m thjA}$	_	65	K/W	_



2.3 Electrical Characteristics

8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Current Consumption

Quiescent current	Is	_	10	20	μA	INH = Low; $V_{\rm S}$ = 13.2 V; $T_{\rm j}$ = 25 °C
Quiescent current	Is	-	-	40	μA	INH = Low; V _s = 13.2 V
Supply current	Is	-	2.0	4.0	mA	-
Logic-Supply current	I _{CC}	-	2	10	μA	INH = Low
Logic-Supply current	I _{CC}	_	1.6	3.0	mA	SPI not active

Over- and Under-Voltage Lockout

		-		-		
UV-Switch-ON voltage	$V_{\rm UVON}$	_	6.5	7.0	V	$V_{\rm S}$ increasing
UV-Switch-OFF voltage	$V_{\rm UVOFF}$	5.5	6.0	6.6	V	$V_{\rm S}$ decreasing
UV-ON/OFF-Hysteresis	$V_{\rm UVHY}$	-	0.5	-	V	$V_{\rm UV ON} - V_{\rm UV OFF}$
OV-Switch-OFF voltage	$V_{\rm OVOFF}$	34	37	40	V	$V_{\rm S}$ increasing
OV-Switch-ON voltage	$V_{\rm OV ON}$	28	32	36	V	$V_{\rm S}$ decreasing
OV-ON/OFF-Hysteresis	$V_{\rm OVHY}$	-	5.0	-	V	$V_{\rm OVOFF}-V_{\rm OVON}$



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Outputs OUTH1-6 and OUTL1-6

Static Drain-Source-On Resistance

Source (High-Side) $I_{OUT} = -0.5 \text{ A}$	$R_{\rm DS \ ON \ H}$	_	0.9	1.3	Ω	8 V < V _S < 40 V T _j = 25 °C
			_	2.0	Ω	8 V < V _S < 40 V
			2.0	_	Ω	$V_{\rm S OFF} < V_{\rm S} \le 8 {\rm V}$ $T_{\rm j}$ = 25 °C
			-	4.0	Ω	$V_{\rm SOFF}$ < $V_{\rm S}$ \leq 8 V
Sink (Low-Side) I _{OUT} = 0.5 A	R _{ds on L}	-	0.8	1.2	Ω	8 V < V _s < 40 V T _j = 25 °C
			-	2.0	Ω	8 V < $V_{\rm S}$ < 40 V
			2.0	_	Ω	$V_{\rm S OFF} < V_{\rm S} \le 8 {\rm V}$ $T_{\rm j}$ = 25 °C
			_	4.0	Ω	$V_{\rm SOFF}$ < $V_{\rm S}$ \leq 8 V

Note: Values of $R_{\text{DS ON}}$ for $V_{\text{S OFF}} < V_{\text{S}} \leq 8$ V are guaranteed by design.

Leakage Current

Source-Output-Stage 1 to 6	I_{QLH}	- 1	_	_	μA	$V_{\rm OUTH1-6} = 0 V$ $T_{\rm j} = 25 ^{\circ}{\rm C}$
Source-Output-Stage 1 to 6	$I_{\rm QLH}$	- 5	-	-	μA	V _{OUTH1-6} = 0 V
Sink-Output-Stage 1 to 6	I_{QLL}	-	_	1	μA	$V_{\text{OUTL1-6}} = V_{\text{S}}$ $T_{\text{j}} = 25 \text{ °C}$
Sink-Output-Stage 1 to 6	$I_{\rm QLL}$	-	-	5	μA	$V_{\text{OUTL1-6}} = V_{\text{S}}$



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Overcurrent

Source shutdown threshold	$I_{\rm SDU}$	- 2.0	- 1.5	- 1.0	А	-
Sink shutdown threshold	$I_{\rm SDL}$	1.0	1.5	2.0	А	-
Current limit	I _{OCL}	_	3.0	5.0	А	sink and source
Shutdown delay time	t _{dSD}	10	25	50	μs	sink and source

Open Circuit

Detection current	I _{OCD}	15	30	50	mA	-
Delay time	t _{dOC}	200	350	600	μs	_

Delay Time from Stand-by to Data In

Setup time	t _{set}	_	_	100	μs	_
	501				•	

Note: setup time is guarnteed by design

Output Delay Times; $V_s = 13.2 \text{ V}$; $R_{\text{Load}} = 25 \Omega$ (device not in stand-by for t > 1 ms)

Source (high-side) ON	t _{d ON H}	-	7.5	12	μs	-
Source (high-side) OFF	t _{d OFF H}	-	3	6	μs	-
Sink (low-side) ON	t _{d ON L}	-	6.5	12	μs	-
Sink (low-side) OFF	t _{d OFF L}	_	2	5	μs	-
Dead time H to L	t _{D HL}	1.5	-	_	μs	$t_{\rm d \ ON \ L} - t_{\rm d \ OFF \ H}$
Dead time L to H	t _{DLH}	2.5	-	_	μs	$t_{\rm d \ ON \ H} - t_{\rm d \ OFF \ L}$



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Output Switching Times; V_s = 13.2 V; R_{Load} = 25 Ω (device not in stand-by for t > 1 ms)

Source (high-side) rise-time	t _{on H}	-	4	8	μs	-
Source (high-side) fall-time	t _{off H}	-	2	3	μs	-
Sink (low-side) fall-time	t _{on L}	-	1	3	μs	-
Sink (low-side) rise-time	t _{off L}	-	1	2	μs	-

Clamp Diodes Forward Voltage

Upper	$V_{\rm FU}$	-	0.9	1.3	V	<i>I</i> _F = 0.5 A
Lower	$V_{\rm FL}$	_	0.9	1.3	V	<i>I</i> _F = 0.5 A

Inhibit Input

H-input voltage threshold	V_{IH}	_	_	0.7	V _{cc}	-
L-input voltage threshold	$V_{\rm IL}$	0.2	-	-	V _{cc}	-
Hysteresis of input voltage	V_{IHY}	50	200	500	mV	-
Pull down current	I	10	25	50	μA	$V_1 = 0.2 \times V_{CC}$
Input capacitance	C	_	10	15	pF	0 V < V _{CC} < 5.25 V

Note: Capacitances are guaranteed by design



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Lir	Limit Values			Test Condition
		min.	typ.	max.		

SPI-Interface Delay Time from Stand-by to Data In

Setup time t_{set} 100 μs -

Logic Inputs DI, CLK and CSN

V_{IH}	-	-	0.7	$V_{\rm CC}$	-
V _{IL}	0.2	_	_	V _{cc}	-
V_{IHY}	50	200	500	mV	-
$I_{\rm ICSN}$	- 50	- 25	- 10	μA	$V_{\rm CSN}$ = 0.7 × $V_{\rm CC}$
$I_{\rm IDI}$	10	25	50	μA	$V_{\rm DI}$ = 0.2 × $V_{\rm CC}$
I _{ICLK}	10	25	50	μA	$V_{\rm CLK}$ = 0.2 × $V_{\rm CC}$
C_{I}	-	10	15	pF	0 V < V _{CC} < 5.25 V
	$V_{\rm IL}$ $V_{\rm IHY}$ $I_{\rm ICSN}$ $I_{\rm IDI}$ $I_{\rm ICLK}$	$\begin{array}{c c} V_{\rm IL} & 0.2 \\ V_{\rm IHY} & 50 \\ I_{\rm ICSN} & -50 \\ I_{\rm IDI} & 10 \\ I_{\rm ICLK} & 10 \end{array}$	$\begin{array}{c cccc} V_{\rm IL} & 0.2 & - & \\ V_{\rm IHY} & 50 & 200 & \\ I_{\rm ICSN} & -50 & -25 & \\ I_{\rm IDI} & 10 & 25 & \\ I_{\rm ICLK} & 10 & 25 & \\ \end{array}$	$\begin{array}{c ccccc} V_{\rm IL} & 0.2 & - & - \\ V_{\rm IHY} & 50 & 200 & 500 \\ I_{\rm ICSN} & -50 & -25 & -10 \\ I_{\rm IDI} & 10 & 25 & 50 \\ I_{\rm ICLK} & 10 & 25 & 50 \end{array}$	$\begin{array}{c ccccc} V_{\rm IL} & 0.2 & - & - & V_{\rm CC} \\ \hline V_{\rm IHY} & 50 & 200 & 500 & mV \\ \hline I_{\rm ICSN} & -50 & -25 & -10 & \mu {\rm A} \\ \hline I_{\rm IDI} & 10 & 25 & 50 & \mu {\rm A} \\ \hline I_{\rm ICLK} & 10 & 25 & 50 & \mu {\rm A} \end{array}$

Note: Capacitances are guaranteed by design

Logic Output DO

H-output voltage level	V _{DOH}	V _{cc} - 1.0	<i>V</i> _{cc} – 0.7	_	V	<i>I</i> _{DOH} = 1 mA
L-output voltage level	$V_{\rm DOL}$	_	0.2	0.4	V	<i>I</i> _{DOL} = – 1.6 mA
Tri-state leakage current	I _{dolk}	- 10	-	10	μA	$V_{\rm CSN} = V_{\rm CC}$ $0 V < V_{\rm DO} < V_{\rm CC}$
Tri-state input capacitance	C _{DO}	_	10	15	pF	$V_{\rm CSN} = V_{\rm CC}$ $0 \ V < V_{\rm CC} <$ $5.25 \ V$

Note: Capacitances are guaranteed by design



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Lin	Limit Values			Test Condition
		min.	typ.	max.		

Data Input Timing

Clock period	t _{pCLK}	1000	_	_	ns	_
Clock high time		500	_	_	ns	
Clock low time		500	_	_	ns	_
Clock low before CSN low		500	_	_	ns	_
CSN setup time	t _{lead}	500	_	_	ns	_
CLK setup time	t_{lag}	500	_	-	ns	_
Clock low after CSN high	t _{beh}	500	_	_	ns	-
DI setup time	t _{DISU}	250	_	_	ns	-
DI hold time	t _{DIHO}	250	_	-	ns	-
Input signal rise time at pin DI, CLK and CSN	t _{rIN}	-	_	200	ns	-
Input signal fall time at pin DI, CLK and CSN	t _{fIN}	-	_	200	ns	-

Data Output Timing

DO rise time	t _{rDO}	_	50	100	ns	<i>C</i> _L = 100 pF
DO fall time	t _{fDO}	-	50	100	ns	<i>C</i> _L = 100 pF
DO enable time	t _{ENDO}	_	_	250	ns	low impedance
DO disable time	t _{DISDO}	-	-	250	ns	high impedance
DO valid time	t _{VADO}	-	100	250	ns	$V_{\rm DO}$ < 0.2 $V_{\rm CC}$; $V_{\rm DO}$ > 0.7 $V_{\rm CC}$; $C_{\rm L}$ = 100 pF



8 V < $V_{\rm S}$ < 40 V; 4.75 V < $V_{\rm CC}$ < 5.25 V; INH = High; all outputs open; – 40 °C < $T_{\rm j}$ < 150 °C; unless otherwise specified

Parameter	Symbol	Lin	Limit Values			Test Condition
		min.	typ.	max.		

Thermal Prewarning and Shutdown

Thermal prewarning junction temperature	$T_{\rm jPW}$	120	145	170	°C	_
Temperature prewarning hysteresis	ΔT	-	30	-	К	-
Thermal shutdown junction temperature	$T_{\rm jSD}$	150	175	200	°C	-
Thermal switch-on junction temperature	T _{jSO}	120	-	170	°C	-
Temperature shutdown hysteresis	ΔT	-	30	-	К	-
Ratio of SD to PW temperature	$T_{ m jSD}$ / $T_{ m jPW}$	1.05	1.20	_	-	-

Note: Temperatures are guaranteed by design



3 Timing Diagrams

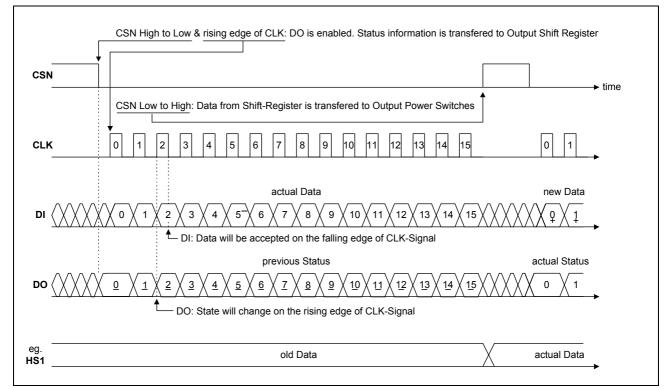


Figure 4 Standard Data Transfer Timing

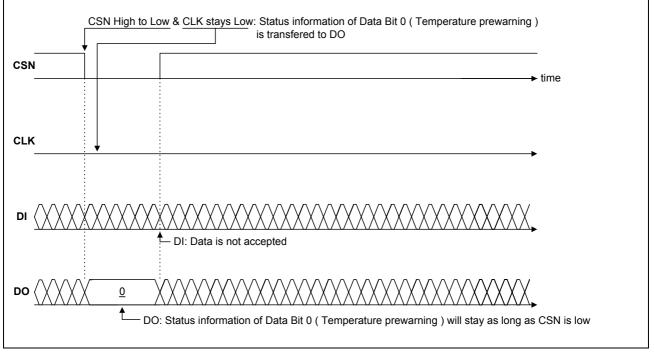


Figure 5 Timing for Temperature Prewarning only



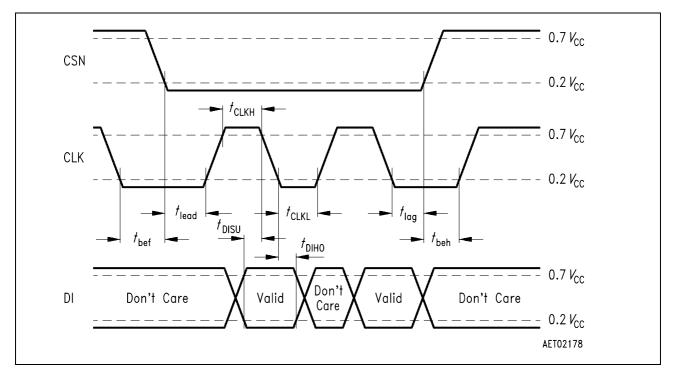


Figure 6 SPI-Input Timing

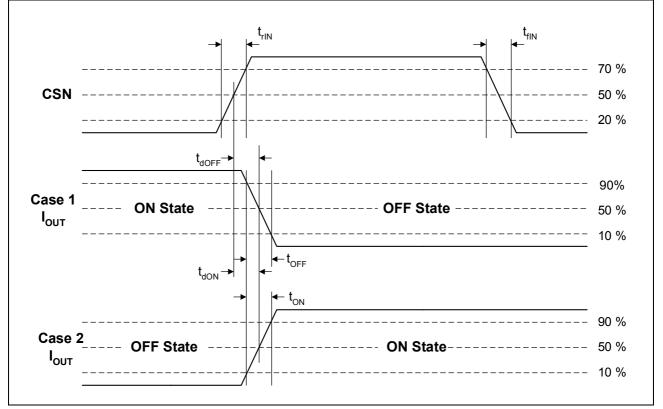


Figure 7 Turn OFF/ON Time

Data Sheet



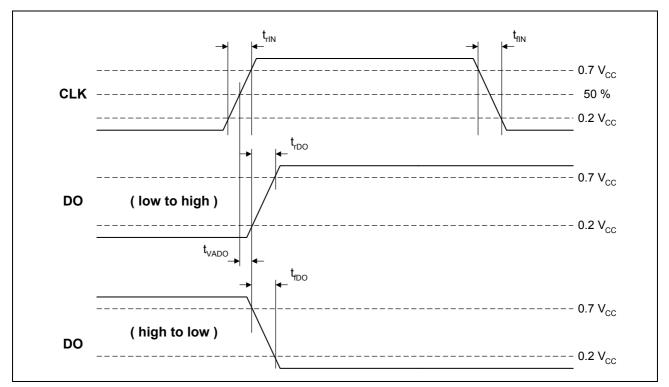


Figure 8 DO Valid Data Delay Time and Valid Time

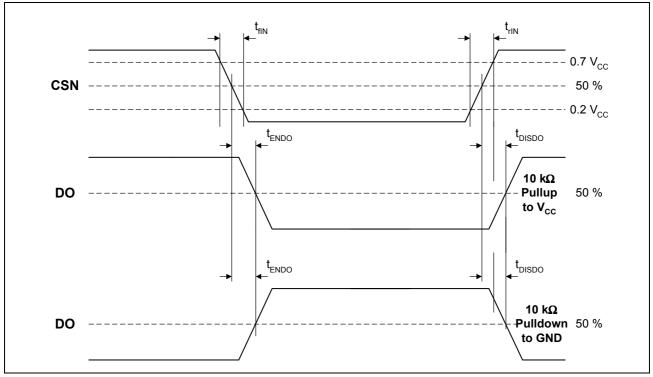


Figure 9 DO Enable and Disable Time



4 Application

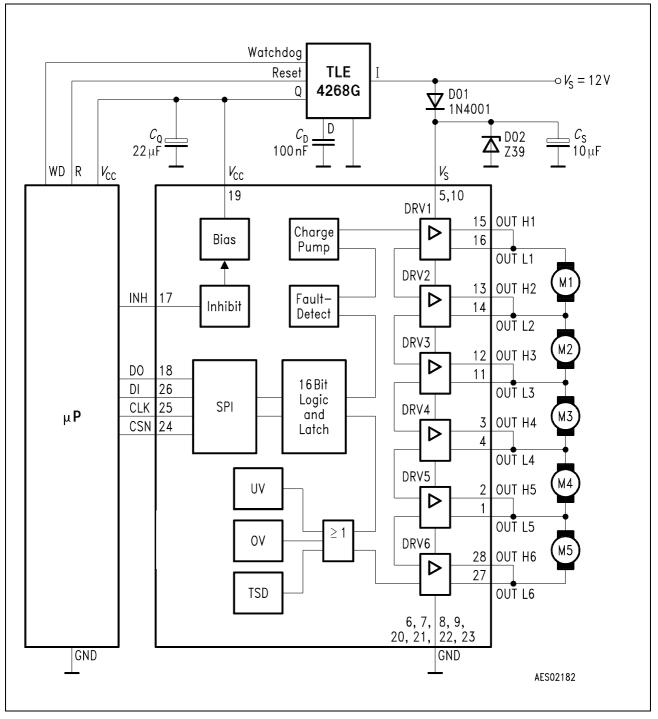
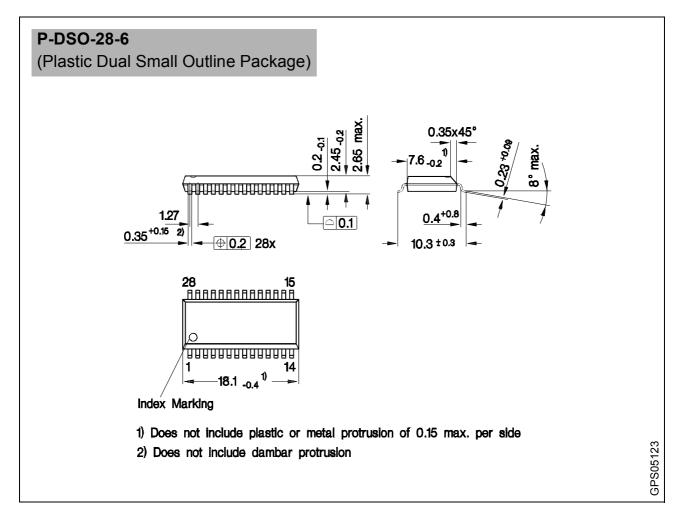


Figure 10 Application Circuit



5 Package Outlines



Sorts of Packing Package outlines for tubes, trays etc. are contained in our Data Book "Package Information". SMD = Surface Mounted Device

Dimensions in mm

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.